

Notice of References Cited	Application/Control No. 10/644,604		Applicant(s)/Patent Under Reexamination WALSH ET AL.	
	Examiner Anthony Weier		Art Unit 1794	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,346,652	08-1982	de Ruyter, Peter W. A.	99/483
*	C	US-4,430,356	02-1984	Ohyabu et al.	426/574
*	D	US-4,517,218	05-1985	Yackel et al.	426/656
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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